

<b>Notice of References Cited</b>	Application/Control No. 10/577,310		Applicant(s)/Patent Under Reexamination UCHIDA ET AL.	
	Examiner BAO LI		Art Unit 1648	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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#### NON-PATENT DOCUMENTS

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	U	Rota et al. Science, May 2003, Vol. 300, No. 5624, pp. 1394-1399.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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